

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10512065	NAKAMURA, HIROTO
	Examiner	Art Unit
	TRUNG Q NGUYEN	2829

SEARCHED

Class	Subclass	Date	Examiner
324	73.1, 158.1, 754-758, 760-765.	07/23/08	QT
209	571-572	07/23/08	QT
439	482, 824	07/23/08	QT
29	840, 832, 843	07/23/08	QT

SEARCH NOTES

Search Notes	Date	Examiner
Keywords: semiconductor\$1 and tray\$1 and mov\$3 and test\$3 and strip\$1 and socket\$1	07/23/08	QT

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
PG-PUB Search	See attached search	07/23/08	QT